Nonequilibrium electron-vibration coupling and conductance fluctuations in a C₆₀ junction

Søren Ulstrup,^{1,*} Thomas Frederiksen,^{2,3} and Mads Brandbyge¹

¹DTU-Nanotech, Department of Micro- and Nanotechnology, Technical University of Denmark, Ørsteds Plads,

²Donostia International Physics Center (DIPC) – UPV/EHU, E-20018 Donostia-San Sebastián, Spain

³IKERBASQUE, Basque Foundation for Science, E-48011, Bilbao, Spain

(Received 3 July 2012; revised manuscript received 21 September 2012; published 17 December 2012)

We investigate chemical bond formation and conductance in a molecular C_{60} junction under finite bias voltage using first-principles calculations based on density functional theory and nonequilibrium Green's functions (DFT-NEGF). At the point of contact formation we identify a remarkably strong coupling between the C_{60} motion and the molecular electronic structure. This is only seen for positive sample bias, although the conductance itself is not strongly polarity dependent. The nonequilibrium effect is traced back to a sudden shift in the position of the voltage drop with a small C_{60} displacement. Combined with a vibrational heating mechanism we construct a model from our results that explain the polarity-dependent two-level conductance fluctuations observed in recent scanning tunneling microscopy (STM) experiments [N. Néel *et al.*, Nano Lett. **11**, 3593 (2011)]. These findings highlight the significance of nonequilibrium effects in chemical bond formation/breaking and in electron-vibration coupling in molecular electronics.

DOI: 10.1103/PhysRevB.86.245417

PACS number(s): 73.63.-b, 68.37.Ef, 61.48.-c

I. INTRODUCTION

The influence of an external bias voltage and electronic currents on the formation and breaking of chemical bonds is a topic of increasing importance with the continued downscaling of electronic components. This is especially accentuated in the limit of single-molecule devices.¹

A substantial current may flow through a single bond, and its effect on the stability and impact on transport is crucial. The phenomenon of random two-level conductance fluctuations (TLF) is generally observed in a wide range of simple atomic and molecular contacts.^{2–6} It is often possible to relate these to changes in the bonding configuration driven by the current. Clearly, controlled and reversible switching between well-defined conductance states is a useful function.⁷ Over the years many examples of atomic^{6,8,9} and molecule-based^{10–22} switches have been demonstrated. However, the understanding of how the nonequilibrium electronic structure impacts chemical bonding and conformational changes still poses many open questions. First-principles calculations and comparisons with well-characterized, time-resolved experiments can shed light on these issues.

Nonequilibrium dynamics of C_{60} systems has been under intense study.^{14,23–25} Here we focus on recently reported time-resolved measurements of single C_{60} contacts with a scanning tunneling microscope (STM),²⁵ which showed that TLF occur in a narrow transition regime between tunneling and contact to C_{60} . The advantage of STM is the possibility to identify the orientation of individual C_{60} molecules^{26,27} before and after controllable formation of the tip-molecule contact.²⁸ Moreover, the role of detailed electrode bonding geometry^{29,30} and contact point on the junction conductance has been clarified.³¹

More specifically, the experiment revealed the following interesting properties: (i) In the tunneling regime dI/dV spectroscopy shows that transport is dominated by the lowest unoccupied molecular orbital (LUMO) (seen as a resonance centered at a positive sample voltage of ~0.4 V), while (ii) in

contact the *I*-V curve is close to linear in the voltage range [-0.4; +0.4] V, suggesting a relatively symmetric coupling of the LUMO resonance to the two electrodes. Intriguingly, (iii) the TLF was only observed at positive sample voltage around contact formation. These findings were discussed in Ref. 25 solely on the basis of dI/dV spectra in the tunnel regime. Essentially, only the spectral properties of the molecular adsorbate in equilibrium with the substrate were considered. Here we present a different view on the experimental findings based on our demonstration of a remarkably strong bias-dependent electronic coupling to the center-of-mass (CM) motion of the C_{60} at the point when a bond is being formed between C₆₀ and the apex atom of the STM tip. From first-principles calculations we obtain a detailed description of the C_{60} -junction geometry as well as the molecular LUMO resonance near the Fermi level. This allows us to construct a model for the TLF, which provides an explanation for the experimental findings. Our results demonstrate that the full nonequilibrium electronic structure needs to be accounted for to understand the observed TLF.

Our paper is organized as follows. In Sec. II we describe the first-principles method and our setup of the C_{60} -contact system. In Sec. III we then describe the results obtained without fitting parameters for the contact formation between the STM tip and C_{60} in equilibrium. Here we identify the formation of the chemical bond between the molecule and the tip apex atom. This is followed by our study of nonequilibrium effects and a discussion of the identified polarity-dependent strong coupling between the C₆₀ CM motion and voltage drop (Sec. IV). From these first-principles calculations we extract in Sec. V parameters for a simple single-resonance model, most importantly the bias-dependent electron-vibration coupling to the CM motion. Together with a few additional parameters the model is used to calculate the TLF behavior, which can be compared to the experiment. Before concluding we discuss how the nonequilibrium forces modify the energy landscape for the CM motion (Sec. VI).

Bldg. 345E, DK-2800 Kongens Lyngby, Denmark

II. METHOD AND SETUP

To study the contact formation and TLF we employ the SIESTA³² density functional theory (DFT) method, and its extension to finite bias using nonequilibrium Green's functions (DFT-NEGF) in the TRANSIESTA scheme.³³ The generalized gradient approximation (GGA-PBE) is applied for exchange and correlation (xc).³⁴

The C₆₀ junction geometry is modeled as shown in the inset to Fig. 1. The periodic supercell used in the DFT calculations contains one C₆₀ molecule supported on top of seven fixed Cu(111) layers (27 Cu atoms per layer) with a pyramidshaped Cu tip mounted on the bottom layer. To accurately describe the Cu surface and the chemical bonding with C₆₀, an optimized diffuse basis set was applied for Cu surface layers and the tip.³⁵ The counterpoise correction³⁶ for the basis set superposition errors (BSSE) was applied to the total energy calculations, which was checked against complementary calculations with the VASP³⁷ plane wave code as shown in Fig. 1(b).

The Γ -point approximation was employed for Brillouin zone integrations in the electronic structure calculation, while the transmission function was sampled over 3×3 k points in the 2D Brillouin zone parallel to the electrode surfaces. The residual atomic forces were lower than 0.02 eV/Å for the atoms that were relaxed. The C₆₀ CM force constant was calculated from DFT total energies corresponding to configurations where the C₆₀ CM was rigidly displaced, up to 0.6 Å from its equilibrium position.



FIG. 1. (Color online) (a) Relaxed bond lengths and (b) corresponding total energy vs electrode separation L. The total energy is determined with respect to the initial configuration. The bond length d_1 (d_2) between C₆₀ center-of-mass (CM) and surface (tip) and the junction geometry are defined in the inset in (a) along with the orientation of C₆₀ with respect to the underlying Cu surface (top right inset) and the tip apex atom (bottom right inset). The C₆₀ is oriented such that the tip apex atom approaches the 5:6 bond.

III. CONTACT FORMATION

We first focus on the bond-formation point at zero bias, and consider the approach of the STM tip towards a 5:6 C_{60} bond, i.e., a bond between a pentagon and a hexagon. We note that the fluctuations were observed for this orientation in the experiments,²⁵ and that no molecular rotations occur during contact formation in either the experiments²⁷ or in our structure optimizations.

We optimize the junction geometry by stepwise reducing the size of the DFT supercell in the direction perpendicular to the surface, while relaxing the C₆₀ and tip atoms. Figure 1(a) shows the relaxed bond lengths d_1 and d_2 , between the C₆₀ center-of-mass (CM) and the surface and the tip atoms, respectively, as a function of electrode separation *L*. Around a characteristic separation $L_0 = 15.96$ Å, the distance d_2 decreases rapidly while d_1 increases dramatically as the cell shrinks. This signals the onset of a chemical bond formation between the STM tip and the C₆₀ molecule. This tip-C₆₀ attraction lowers the total energy of the system as witnessed by the binding energy curve in Fig. 1(b).

The corresponding vibrational energy $\hbar\Omega$ associated with the C₆₀ CM motion as well as the zero-bias conductance $G = G_0T(E_F)$ (conductance quantum $G_0 = 2e^2/h$) of the junction are shown in Fig. 2 in the transition regime between tunneling and contact for the DFT equilibrium geometries. At L_0 we find three eigenchannels contributing to the total transmission $T(E_F)$ with the values {0.16,0.006,0.002}. The first channel dominates the transmission, because the three-fold degeneracy of the C₆₀ LUMO has been lifted.^{38,39} Thus, the C₆₀ symmetry is broken in the contact configuration. One observes that the bond formation to the tip softens the C₆₀ vibration [Fig. 2(a)] and increases the conductance by roughly a factor of 2.5 [Fig. 2(b)]. We note that the calculated conductance value of the order $G = 0.2G_0$ agrees very well with the experimental conductance in the transition region between



FIG. 2. (Color online) (a) Vibrational energy $\hbar\Omega$ of the C₆₀ center-of-mass (CM) motion between the electrodes, and (b) zerobias conductance *G* of the junction vs electrode separation *L* in the transition regime between tunneling and contact for the DFT equilibrium geometries.

tunneling and contact where the TLF occur.²⁵ Moreover, the calculated vibrational energies agree with a recent theoretical study of the C_{60} CM motion on the Au(111) surface.⁴⁰

According to our equilibrium DFT calculations we could not identify two well-defined stable configurations (for any fixed electrode separation) which could explain the existence of two different conductance states. Instead we observe a shallow energy landscape around the point of contact formation indicating that C_{60} is rather free to move between the electrodes (e.g., the softening of the C_{60} CM mode). We therefore speculate that a small barrier of the order of 10 meV, separating two distinct configurations, could be masked by limited numerical accuracy or by inherent approximations in the applied xc functional. In fact, recent theoretical studies of a somewhat simpler system consisting of graphene on Ni(111)have shown that various xc functionals can yield differences in the potential energies describing the carbon-metal distance much beyond the energies relevant for our system.^{41,42} The disregard of current-induced forces acting on the atoms could also play an important role in the energy landscape,⁴³ a point we return to at the end of this paper. Finally, we note that the actual experiments involve a complex reconstructed surface structure which we did not take into account. Because of these circumstances we shall therefore in our TLF model (Sec. V) postulate the existence of two configurations in the contact region separated by a small barrier (on the order of DFT accuracy), and instead focus our attention on the electron-CM vibration coupling and the resulting current-induced heating, which can explain the observed polarity-dependent TLF.

As the electrode separation L_0 is characteristic for the point of tip- C_{60} bond formation, we take this configuration as the starting point for an exploration of how the nonequilibrium electronic structure and electron transport depend on C_{60} motion. Figure 3(a) shows the transmission spectra (with a prominent LUMO resonance) for several positions Δd_1 of C_{60} between the electrodes under three different applied sample voltages V_S . In each situation the transmission function is approximately given by a Breit-Wigner function^{44,45}

$$T(E, V_S) \approx 2\pi \frac{\Gamma_T \Gamma_S}{\Gamma_T + \Gamma_S} [\rho_T(E, V_S) + \rho_S(E, V_S)], \quad (1)$$

where

$$\rho_{T(S)}(E, V_S) = \frac{1}{2\pi} \frac{\Gamma_{T(S)}}{[E - \varepsilon_0(V_S)]^2 + [(\Gamma_T + \Gamma_S)/2]^2} \quad (2)$$

is the partial density of states of the LUMO resonance, positioned at $\varepsilon_0(V_S)$, due to the coupling $\Gamma_{T(S)}$ to the tip (sample) electrode (neglecting energy dependence in $\Gamma_{T(S)}$). We take the equilibrium Fermi energy $\varepsilon_F = 0$ as the energy reference and define the tip and surface chemical potentials as $\mu_T = V_S/2$ and $\mu_S = -V_S/2$, respectively. The resonance parameters $\{\varepsilon_0, \Gamma_T, \Gamma_S\}$ are readily fitted to the DFT-NEGF calculations as a function of C₆₀ position and voltage, as shown in Fig. 3(b).

IV. VOLTAGE DROP

Remarkably, the nonequilibrium electronic structure reveals a strong variation of ε_0 with C₆₀ position for positive sample voltages. This is a central finding of this work and below we shall show that it can explain the strong polarity

dependence of the TLF seen in the experiments. In Fig. 3(c) we illustrate this by plotting the change in ε_0 relative to μ_S , as a function of μ_T for the various C₆₀ displacements. For $\mu_T < 0$ the ε_0 mainly follows μ_S , while for $\mu_T > 0$ a small



FIG. 3. (Color online) (a) Transmission spectra $T(E, V_S)$ for different sample bias voltage V_S as the C₆₀-surface bond length is increased by Δd_1 . Data points correspond to DFT-NEGF simulations and solid lines are fits to the Breit-Wigner formula [Eq. (1)] for the transmission through a single molecular orbital. (b) Fitted LUMO level position ϵ_0 and coupling functions Γ_S and Γ_T due to the surface and tip coupling, respectively, and (c) voltage drop across the C₆₀-surface interface as a function of μ_T and Δd_1 . The solid lines in (b) and (c) are guides to the eye.



FIG. 4. (Color online) (a) Simple model calculation of the change in resonance position assuming charge neutrality of the resonance at finite bias. We use $\varepsilon_0 = 0.1 \text{ eV}$, $\Gamma_S + \Gamma_T = 0.2 \text{ eV}$ (fixed), and vary Γ_T / Γ_S (distance to tip). The main voltage drop occurs between tip and C₆₀ (resonance) for $V_S < 0$ and small tip coupling, while it shifts to the C₆₀-substrate interface for $V_S > 0$ and stronger tip coupling. (b) Voltage drop (change in DFT one-electron potential) calculated for increasing C₆₀-surface bond length at a positive sample bias of 0.5 V. The voltage difference between consecutive contour lines is 18 mV (shown in a plane through the tip atom).

increase in d_1 and thus coupling to the tip, makes ε_0 follow μ_T rather than μ_S , despite $\Gamma_S > \Gamma_T$.

The voltage dependence of ε_0 , or equivalently the voltage profile across the junction, can be understood roughly as a disposition of the system to maintain a constant electron charge Q in the resonance.⁴⁶ In order to illustrate this we consider a simple model calculation. Within the resonance model the LUMO charge is given by

$$Q(V_S) = \int_{-\infty}^{\mu_T} \rho_T(E, V_S) dE + \int_{-\infty}^{\mu_S} \rho_S(E, V_S) dE \,.$$
(3)

If we assume constant LUMO charge independent of the applied bias, i.e., $Q(V_S) = Q(0)$, we may determine the biasdependent change in LUMO position, $\delta \varepsilon_0(V_S)$ from Eq. (3). To mimic the change in C_{60} -tip distance d_2 for fixed electrode distance L, we vary Γ_T / Γ_S for fixed $\Gamma_T + \Gamma_S$. In Fig. 4(a) it is seen how this simplified model reproduces the crossover in the full DFT calculation [Fig. 3(c)] for positive sample voltage when the contact is formed. Thus the main voltage drop changes from being between tip and C_{60} for $V_S < 0$ to being between surface and C_{60} when $V_S > 0$ and the distance to the tip is decreased ($|\delta \varepsilon_0 - \mu_S| > |\delta \varepsilon_0 - \mu_T|$). From Eq. (3) we can thus infer that in nonequilibrium there is a sensitive balance between coupling strengths ($\Gamma_{T/S}$) and electrode chemical potentials $(\mu_{T/S})$ that can displace the voltage drop from one interface to the other with a small relative change in coupling strengths.

This effect in Fig. 3 can also be seen directly in the actual voltage drop landscape (change in the one-electron potential with respect to equilibrium) shown in Fig. 4(b). The voltage drop is observed to shift from the C₆₀-tip interface to the C₆₀-substrate interface with a small C₆₀ displacement, an effect not present for $V_S < 0$ (not shown).

V. HEATING AND FLUCTUATIONS

We next explain how the strong variation of ε_0 with C_{60} position for $V_S > 0$ can be related to the strong polarity dependence of the TLF. We start by assuming that the main current dependence comes from the excitation of C_{60} CM motion, described by a harmonic potential with $\hbar\Omega \approx 4$ meV [cf. Fig. 2(a) at L_0]. Guided by the fact that the switching rates observed in the experiments (ms time scale) are very slow compared to CM oscillations, we propose that the switching involves a slow "bottle-neck" process, possibly involving tunneling along the reaction coordinate (RC), and that this process takes place when the excursion of the C_{60} (Δd_1) is beyond some critical distance from the equilibrium position. Inspired by the study of tunneling of a C_{60} molecule in the low-conductance regime¹⁴ we express the switching rate as

$$R(V_S) = r_s e^{-d_c^2/\langle \Delta d_1(V_S)^2 \rangle} = r_s e^{-\Delta/\langle E_{\rm CM}(V_S) \rangle},\tag{4}$$

i.e., as a product of the probability of C_{60} being at an excursion $\Delta d_1 = d_c$ away from equilibrium and of a rate r_s describing the slow process along the RC. The critical distance d_c , or equivalently the energy barrier Δ , controls how far the C_{60} needs to move in order to facilitate switching. The mean displacement $\langle \Delta d_1^2 \rangle$, or equivalently the mean oscillator energy $\langle E_{\rm CM}(V_S) \rangle$, are quantities which we can calculate within our TLF model.

The excitation of the C₆₀-CM motion by the current is determined from the electronic coupling to this motion. Using Fig. 3(b) we extract the electron-vibration coupling M from the shift in resonance position with C₆₀-displacement d_1 via⁴⁷

$$M(V_S) \approx \frac{l_0}{\sqrt{2}} \,\partial_{d_1} \varepsilon_0(V_S). \tag{5}$$

We evaluate the slope $\partial_{d_1} \varepsilon_0(V_S)$ around $\Delta d_1 = 0.3$ Å, which is in the middle of the transition region [Fig. 3(b)], and note that the slope does not change significantly as we increase Δd_1 . The characteristic oscillator length is $l_0 = \sqrt{\hbar/m\Omega} \approx 0.04$ Å (C₆₀ mass *m*), which is comparable to the size of the transition region in Fig. 2. The extracted electron-vibration coupling *M* is shown in Fig. 5 as a function of sample voltage. A remarkably strong enhancement is evident for $V_S > 0$.

The excitation of the CM motion, as seen in its mean energy $\langle E_{\rm CM}(V_S) \rangle$, can be obtained from the bias-dependent rates of phonon emission $\gamma_{\rm em}(V_S)$ and of electron-hole pair generation $\gamma_{\rm eh}(V_S)$. These rates can be determined within first order perturbation theory (Fermi's Golden rule). Since $\hbar\Omega$ is much smaller than all other electronic parameters, we may write

$$\gamma_{\rm em}(V_S) \approx \frac{4\pi}{\hbar} |M(V_S)|^2 \theta \left(\frac{e|V_S|}{\hbar\Omega} - 1\right) \\ \times \int_{-|V_S|/2}^{|V_S|/2} \rho_S(E, V_S) \rho_T(E, V_S) dE, \qquad (6)$$



FIG. 5. Calculated electron-vibration coupling |M| for the C₆₀ CM motion (black squares) as a function of sample voltage V_S , based on fits to the LUMO resonance in the transition region at the electrode separation L_0 .

$$\gamma_{\rm eh}(V_S) \approx 4\pi |M(V_S)|^2 \Omega[\rho(\mu_T, V_S)\rho_T(\mu_T, V_S) + \rho(\mu_S, V_S)\rho_S(\mu_S, V_S)],$$
(7)

where $\rho = \rho_T + \rho_S$. From these rates we can write a rate equation for the mean phonon occupation $\langle n(V_S) \rangle$,

$$\langle \dot{n}(V_S) \rangle = \gamma_{\rm em}(V_S) - \{\gamma_{\rm eh}(V_S) + \gamma_{\rm ph}\}\{\langle n(V_S) \rangle - n_B\}, \quad (8)$$

where γ_{ph} represents the vibrational relaxation due to anharmonic coupling to phonons in tip/substrate and n_B is the Bose-Einstein (equilibrium) phonon occupation of the considered mode. The steady-state solution is simply

$$\langle n(V_S) \rangle = n_B + \frac{\gamma_{\rm em}(V_S)}{\gamma_{\rm eh}(V_S) + \gamma_{\rm ph}}.$$
 (9)

Following Refs. 47 and 48 one can estimate a phonon damping to the substrate of C_{60} -CM motion via the formula

$$\gamma_{\rm ph} = \frac{m}{m_{\rm Cu}} \frac{3\pi}{2\omega_e^3} \Omega^4 \approx 0.1\Omega, \qquad (10)$$

where $m_{\rm Cu}$ is the mass of a substrate atom, and $\omega_e = 30 \text{ meV}$ a frequency characterizing the elastic response. This damping is likely to be exaggerated compared to the experimental situation since the C_{60} is adsorbed on a reconstructed surface with low-coordinated surface atoms and lower density of long wavelength phonons. This is a critical point for the explanation of the experimental result. We find that the best agreement is obtained for $\gamma_{ph}\approx 0.001\Omega.$ In Fig. 6 we show how $\gamma_{em},$ $\gamma_{\rm eh}$, and $\langle n \rangle$ varies with the sample voltage V_S along with the effective temperature defined through a Bose-Einstein distribution $\langle n(V_S) \rangle = 1/(e^{\hbar \Omega/k_B T_{\rm eff}(V_S)} - 1)$. In all cases we see an enhancement for $V_S > 0$. If we use $\gamma_{\rm ph} \approx 0.1\Omega$ the mean occupation and effective temperature become a factor 100 smaller, but exhibit the same behavior as in Figs. 6(c)-6(d). Finally we can calculate the oscillator energy as $\langle E_{\rm CM}(V_S) \rangle =$ $\hbar\Omega(\langle n(V_S) \rangle + 1/2)$ and thus the current-dependent rate from Eq. (4).

Figure 7(a) shows how the calculated switching yield $Y(V_S)$ (blue squares), defined as the switching rate per tunneling electron, can reproduce the experimental data (red circles) if we use a barrier height of $\Delta = 2\hbar\Omega$, a "tunnel-rate" $r_s =$ $80 \,\mathrm{ms}^{-1}$, $\gamma_{\rm ph} \sim 0.001\Omega$, and a background temperature of T =14 K as fitting parameters. The slightly elevated temperature, compared to the experiment performed at T = 7 K, helps to



FIG. 6. (Color online) Rates of (a) electron-hole pair generation, (b) phonon emission, and resulting (c) mean phonon occupation as a function of sample bias for $\gamma_{\rm ph} \sim 0.001\Omega$. (d) Effective temperature $T_{\rm eff}(V_S)$ corresponding to the mean phonon occupation in (c).

smooth the onset of the switching rate at small voltages. This can be justified by vibrational heating of other modes and their anharmonic coupling to the CM motion of the C_{60} . The relatively slow r_s is consistent with a tunneling process, and the



FIG. 7. (Color online) (a) Calculated switching yield $Y(V_S)$ (blue squares) based on the excitation of the C₆₀ CM motion ($\hbar\Omega = 4$ meV) using Eq. (4) with $r_s = 80 \text{ ms}^{-1}$, T = 14 K, and $\Delta = 2\hbar\Omega$. (b) Switching yield in the case of constant electron-vibration coupling, $M(V_S) = M(V_S = 0)$. (c) Same as (a) but with $\gamma_{\text{ph}} \sim 0.1\Omega \ll \gamma_{\text{eh}}$. For comparison also the experimental data from Ref. 25 are shown (red circles).

small Δ is consistent with the fact that we could not determine the barrier with our DFT calculations.

In Fig. 7(b) we show the calculated fluctuation rate in the case of constant zero-bias electron-vibration coupling where only the spectral energy dependence of the molecule are considered, cf. the explanation presented in Ref. 25 for the polarity dependence. However, it is clear that we are only able to reproduce the experimental results if we take the behavior of the electron-vibration matrix element with bias into account. These findings suggest that (i) the strong polarity dependence of the switching is rooted in the nonequilibrium electron-vibration coupling in the transition region where the bond formation between tip and C_{60} takes place, and (ii) that the reason for the observed saturation of the switching rate per electron is due to the steadily increasing electron-hole pair damping with bias, Eq. (8), so this becomes comparable with $\gamma_{\rm ph}$. This is an important point as illustrated in Fig. 7(c) where we show how the switching yield using the estimate $\gamma_{\rm ph} = 0.1\Omega$ grows for $V_S > 0.2$ V (contrary to the experiment).

We note that the calculated current is roughly linear in voltage as in the experiments, and thus do not contribute significantly to the polarity dependence of the switching compared to the pronounced effect seen in Fig. 5 for the electron-vibration coupling M. We further note that one theoretical study⁴⁹ has previously reported a nonlinear, polarity-*independent* M for a smaller symmetric molecular junction and only at significantly higher voltages V > 0.4 V.

VI. EFFECT OF CURRENT-INDUCED FORCE

In this section we estimate the change in the potential energy landscape in Fig. 1(b) when a nonequilibrium force is exerted on the C₆₀-tip bond during contact formation. To calculate this additional bond force we consider the interaction between the C₆₀ LUMO resonance and a wide band centered on the tip (see inset in Fig. 8). For this system we define the following two-site Hamiltonian

$$\mathbf{H} = \begin{pmatrix} \varepsilon_0(d_2, V_S) & t(d_2, V_S) \\ t(d_2, V_S) & \mu_T(V_S) \end{pmatrix},\tag{11}$$



FIG. 8. (Color online) Equilibrium DFT total energy from Fig. 1(b) plus an additional contribution due to a (conservative) current-induced force. Note that energy is here plotted against C₆₀-tip bond length d_2 instead of electrode separation. Inset: Simple model describing a bond between the molecular resonance at ϵ_0 and a wide band centered on the tip, which follows the chemical potential μ_T .

where we explicitly stress the dependence on bias and bond length d_2 . The interaction strength $t(d_2, V_S)$ is calculated using $\Gamma_T(d_2, V_S) = 2\pi \gamma_T |t(d_2, V_S)|^2$, where γ_T is the wide band density of states on the tip, i.e., a constant which can be fitted to reproduce the transmission spectra in Fig. 3(a). The bond force is calculated using the general expression⁵⁰

$$F_b(d_2, V_S) = -2 \operatorname{Tr}[(\partial_{d_2} \mathbf{H}) \mathbf{D}] = -2[D_{11}\partial_{d_2}\varepsilon_0(d_2, V_S) + 2D_{12}\partial_{d_2}t(d_2, V_S)], (12)$$

where a factor of 2 is included to account for spin. The elements, D_{11} and $D_{12}(=D_{21})$ of the density matrix **D** are determined from the spectral properties of the considered states,⁵¹ which can be calculated from the fits in Fig. 3(b).

Since we only consider motion along a single coordinate the current-induced force is energy conserving, $\delta F_b(d_2, V_S) = F_b(d_2, V_S) - F_b(d_2, 0)$, enabling us to calculate the change in bond energy at a given bias,

$$\Delta E_b(d_2, V_S) = -\int_{d_{2,i}}^{d_2} \delta F_b(z, V_S) \, dz.$$
(13)

The integration limits are defined such that initially a contact is established, $d_{2,i} \approx 5.6$ Å cf. the equilibrium curve in Fig. 8, and then we integrate along a path where the C₆₀-tip contact is gradually separated. Addition of the energy term in Eq. (13) on top of the equilibrium total energy in Fig. 1(b) yields the bias-corrected curves shown in Fig. 8. Astoundingly, we see that only at positive V_S a tiny barrier of the order of a few meV may appear between two stable configurations corresponding to contact and tunneling cases, respectively. The origin of the significant lowering of the tunneling part of the binding energy curve for positive V_S is related to the asymmetry in resonance position, which yields a large contribution from $\partial_{d_2} \varepsilon_0$ in Eq. (12) only at positive V_S . Finally, we note that the order of magnitude of the nonequilibrium barrier is in accordance with our assumption in the fluctuation calculation in Fig. 7.

VII. CONCLUSIONS

In summary, we have presented the results of first-principles calculations which combined with a heating model and assuming a small energy barrier can explain the experimentally observed bias-dependent TLF observed in a C₆₀ STM junction. Our main point is that the electron-vibration coupling can depend very strongly on the bias polarity. In this system we can trace this back to the sensitivity of the nonequilibrium electronic structure/voltage drop with respect to the C₆₀ motion just when the contact is being formed. The bias dependence of the electron-vibration coupling has so far not been considered in most calculations of inelastic electron transport and currentinduced excitations. It remains to be answered to what extend this is important in general. In order to model the experimental switching we had to assume a small energy barrier for the C_{60} motion at the contact formation point. Although it is likely that the small barrier is masked by inaccuracy inherent in the DFT, the finite unit-cell employed, or numerical error, we showed that the nonequilibrium can induce significant changes in the potential energy surface. Our estimate of the current-induced force exerted on the C₆₀-tip bond did indeed indicate an energy barrier for positive sample voltage.

In the presence of a significant current a number of different excitation mechanisms can become active. Recently, it has been discussed how current-induced forces can lead to "runaway" instabilities such as bond-rupture for highly conducting systems $G \sim G_0$, and voltages in the range involved in the present experiment.^{52,53} TLF experiments seem to be a promising way to probe these. The runaway effect requires the action of several vibration modes and we have limited our discussion here to a single mode. Our results demonstrate how the full nonequilibrium electronic structure can be of crucial

- *Present address: Department of Physics and Astronomy, Interdisciplinary Nanoscience Center, Aarhus University, 8000 Aarhus C, Denmark.
- ¹M. Galperin, M. A. Ratner, A. Nitzan, and A. Troisi, Science **319**, 1056 (2008).
- ²N. Agraït, J. Rodrigo, and S. Viera, Phys. Rev. B **47**, 12345 (1993).
- ³Z. Donhauser, B. Mantooth, K. Kelly, L. Bumm, J. Monnell, J. Stapleton, D. Price, A. Rawlett, D. Allara, J. Tour *et al.*, Science **292**, 2303 (2001).
- ⁴R. Wassel, R. Fuierer, N. Kim, and C. Gorman, Nano Lett. **3**, 1617 (2003).
- ⁵W. H. A. Thijssen, D. Djukic, A. F. Otte, R. H. Bremmer, and J. M. van Ruitenbeek, Phys. Rev. Lett. **97**, 226806 (2006).
- ⁶A. Sperl, J. Kröger, and R. Berndt, Phys. Rev. B **81**, 035406 (2010).
- ⁷S. J. v. d. Molen and P. Liljeroth, J. Phys.: Condens. Matter **22**, 133001 (2010).
- ⁸D. M. Eigler, C. P. Lutz, and W. E. Rudge, Nature (London) **352**, 600 (1991).
- ⁹J. A. Stroscio and R. J. Celotta, Science 306, 242 (2004).
- ¹⁰B. C. Stipe, M. A. Rezaei, and W. Ho, Phys. Rev. Lett. **81**, 1263 (1998).
- ¹¹B.-Y. Choi, S.-J. Kahng, S. Kim, H. Kim, H. W. Kim, Y. J. Song, J. Ihm, and Y. Kuk, Phys. Rev. Lett. **96**, 156106 (2006).
- ¹²J. Henzl, M. Mehlhorn, H. Gawronski, K.-H. Rieder, and K. Morgenstern, Angew. Chem. Int. Ed. **45**, 603 (2006).
- ¹³P. Liljeroth, J. Repp, and G. Meyer, Science **317**, 1203 (2007).
- ¹⁴A. V. Danilov, P. Hedegård, D. S. Golubev, T. Bjørnholm, and S. E. Kubatkin, Nano Lett. 8, 2393 (2008).
- ¹⁵A. Halbritter, P. Makk, S. Csonka, and G. Mihaly, Phys. Rev. B **77**, 075402 (2008).
- ¹⁶M. L. Trouwborst, E. H. Huisman, S. J. van der Molen, and B. J. van Wees, Phys. Rev. B **80**, 081407 (2009).
- ¹⁷T. Kumagai, M. Kaizu, H. Okuyama, S. Hatta, T. Aruga, I. Hamada, and Y. Morikawa, Phys. Rev. B **79**, 035423 (2009).
- ¹⁸F. Mohn, J. Repp, L. Gross, G. Meyer, M. S. Dyer, and M. Persson, Phys. Rev. Lett. **105**, 266102 (2010).
- ¹⁹R. Ohmann, L. Vitali, and K. Kern, Nano Lett. 10, 2995 (2010).
- ²⁰T. Brumme, O. A. Neucheva, C. Toher, R. Gutierrez, C. Weiss, R. Temirov, A. Greuling, M. Kaczmarski, M. Rohlfing, F. S. Tautz *et al.*, Phys. Rev. B **84**, 115449 (2011).
- ²¹T. Huang, J. Zhao, M. Feng, A. A. Popov, S. Yang, L. Dunsch, and H. Petek, Nano Lett. **11**, 5327 (2011).
- ²²T. Kumagai, A. Shiotari, H. Okuyama, S. Hatta, T. Aruga, I. Hamada, T. Frederiksen, and H. Ueba, Nat. Mater. **11**, 167 (2012).

importance for the formation/breaking of chemical bonds and electron-vibration coupling in the presence of current.

ACKNOWLEDGMENTS

We are grateful to Richard Berndt, Jörg Kröger, and Nicolás Néel for stimulating discussions and comments on an early version of our manuscript. We are also thankful to Hiromu Ueba for valuable suggestions. We also acknowledge computer resources from the DCSC.

- ²³H. Park, J. Park, A. K. L. Lim, E. H. Anderson, A. P. Alivisatos, and P. L. McEuen, Nature (London) **407**, 57 (2000).
- ²⁴G. Schulze, K. J. Franke, A. Gagliardi, G. Romano, C. S. Lin, A. L. Rosa, T. A. Niehaus, T. Frauenheim, A. D. Carlo, A. Pecchia *et al.*, Phys. Rev. Lett. **100**, 136801 (2008).
- ²⁵N. Néel, J. Kröger, and R. Berndt, Nano Lett. **11**, 3593 (2011).
- ²⁶J. A. Larsson, S. D. Elliott, J. C. Greer, J. Repp, G. Meyer, and R. Allenspach, Phys. Rev. B 77, 115434 (2008).
- ²⁷N. Néel, J. Kröger, L. Limot, and R. Berndt, Nano Lett. 8, 1291 (2008).
- ²⁸N. Néel, J. Kröger, L. Limot, T. Frederiksen, M. Brandbyge, and R. Berndt, Phys. Rev. Lett. **98**, 065502 (2007).
- ²⁹G. Schull, T. Frederiksen, M. Brandbyge, and R. Berndt, Phys. Rev. Lett. **103**, 206803 (2009).
- ³⁰G. Schull, T. Frederiksen, A. Arnau, D. Sanchez-Portal, and R. Berndt, Nat. Nanotechnol. **6**, 23 (2011).
- ³¹G. Schull, Y. J. Dappe, C. González, H. Bulou, and R. Berndt, Nano Lett. **11**, 3142 (2011).
- ³²J. M. Soler, E. Artacho, J. D. Gale, A. Garcia, J. Junquera, P. Ordejon, and D. Sanchez-Portal, J. Phys.: Condens. Matter 14, 2745 (2002).
- ³³M. Brandbyge, J.-L. Mozos, P. Ordejon, J. Taylor, and K. Stokbro, Phys. Rev. B **65**, 165401 (2002).
- ³⁴J. P. Perdew, K. Burke, and M. Ernzerhof, Phys. Rev. Lett. 77, 3865 (1996).
- ³⁵S. Garcia-Gil, A. Garcia, N. Lorente, and P. Ordejon, Phys. Rev. B **79**, 075441 (2009).
- ³⁶S. F. Boys and F. Bernardi, Mol. Phys. **19**, 553 (1970).
- ³⁷G. Kresse and J. Furthmüller, Phys. Rev. B 54, 11169 (1996).
- ³⁸I. D. Hands, J. L. Dunn, and C. A. Bates, Phys. Rev. B **81**, 205440 (2010).
- ³⁹B. W. Heinrich, M. V. Rastei, D.-J. Choi, T. Frederiksen, and L. Limot, Phys. Rev. Lett. **107**, 246801 (2011).
- ⁴⁰I. Hamada, A. Araidai, and M. Tsukada, Phys. Rev. B **85**, 121401(R) (2012).
- ⁴¹M. Vanin, J. J. Mortensen, A. K. Kelkkanen, J. M. Garcia-Lastra, K. S.Thygesen, and K. W. Jacobsen, Phys. Rev. B **81**, 081408(R) (2010).
- ⁴²J. Wellendorff, K. T. Lundgaard, A. Møgelhøj, V. Petzold, D. D. Landis, J. K. Nørskov, T. Bligaard, and K. W. Jacobsen, Phys. Rev. B **85**, 235149 (2012).
- ⁴³A. A. Dzhioev and D. S. Kosov, J. Chem. Phys. **135**, 074701 (2011).
- ⁴⁴S. Datta, *Electronic transport in mesoscopic systems* (Cambridge University Press, Cambridge, 1995).
- ⁴⁵F. D. Novaes, M. Cobian, A. Garcia, P. Ordejon, H. Ueba, and N. Lorente, arXiv:1101.3714v1.

- ⁴⁶M. Brandbyge, N. Kobayashi, and M. Tsukada, Phys. Rev. B **60**, 17064 (1999).
- ⁴⁷S. Gao, M. Persson, and B. I. Lundqvist, Phys. Rev. B **55**, 4825 (1997).
- ⁴⁸J. Leiro and M. Persson, Surf. Sci. **207**, 473 (1989).
- ⁴⁹N. Sergueev, D. Roubtsov, and H. Guo, Phys. Rev. Lett. **95**, 146803 (2005).
- ⁵⁰T. N. Todorov, J. Hoekstra, and A. P. Sutton, Philos. Mag. B **80**, 421 (2000).
- ⁵¹M. Brandbyge, K. Stokbro, J. Taylor, J.-L. Mozos, and P. Ordejon, Phys. Rev. B **67**, 193104 (2003).
- ⁵²D. Dundas, E. J. McEniry, and T. N. Todorov, Nat. Nanotechnol. 4, 99 (2009).
- ⁵³J.-T. Lu, M. Brandbyge, and P. Hedegard, Nano Lett. **10**, 1657 (2010).